

<b>Notice of References Cited</b>	Application/Control No. 10/762,574	Applicant(s)/Patent Under Reexamination UMEZAWA ET AL.	
	Examiner Kevin M. Bernatz	Art Unit 1773	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,602,612	08-2003	Abarra et al.	428/611
*	B	US-5,846,648	12-1998	Chen et al.	428/332
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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